that the device can be made by a different method and that the method can be used to make a different device is not relevant to the analysis under the PCT rules.

Claims 1-9 are clearly linked by a single inventive concept. Claim 1 recites an electronic device comprising a free-standing thin film and claim 8 recites a method of manufacturing an electronic device comprising a free-standing thin film. Both claims 1 and 8 recite "an alloy of aluminum and at least magnesium."

Ignoring both the letter and the spirit of the PCT rules, the Examiner states that the groups do not relate to a single general inventive concept because the inventive feature is known from Zhang ("Mechanical Tests of Free-Standing Aluminum Microbeams for MEMS Application"). This conclusion is clearly wrong. A careful review of Zhang makes clear that the paper does not disclose any teaching of a thin film comprising an alloy of aluminum and magnesium. In contrast to this, Zhang discusses thin films of either pure aluminum or alloys of aluminum and titanium. See Conclusions on page 213 ("We studied the mechanical properties as well as alloying effects of pure Al and Al-2%Ti free-standing micro beams").

In fact, this paper is already discussed on page 1, lines 7 to 21 of the present application. Here, it is also discussed that the free-standing film of an alloy of aluminum and titanium turns out to be very sensitive to creep. A thin film comprising an alloy of aluminum and magnesium is much less sensitive to creep. This is extensively discussed in the present description and shown by various experiments. Accordingly, a thin film according to the present invention provides significant advantages over a thin film according to Zhang.

Examination of claims 1-9 is respectfully requested.

Respectfully submitted,

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